

NTHS5441

Power MOSFET

-20 V, -5.3 A, P-Channel ChipFET™

Features

- Low $R_{DS(on)}$
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package
- Pb-Free Package is Available

Applications

- Power Management in Portable and Battery-Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Rating | Symbol | 5 sec | Steady State | Unit |
|--|----------------|--------------|--------------|------------------|
| Drain-Source Voltage | V_{DS} | -20 | | V |
| Gate-Source Voltage | V_{GS} | ± 12 | | V |
| Continuous Drain Current ($T_J = 150^\circ\text{C}$) (Note 1) $T_A = 25^\circ\text{C}$ $T_A = 85^\circ\text{C}$ | I_D | -5.3 -3.8 | -3.9 -2.8 | A |
| Pulsed Drain Current | I_{DM} | ± 20 | | A |
| Continuous Source Current (Note 1) | I_S | -5.3 | -3.9 | A |
| Maximum Power Dissipation (Note 1) $T_A = 25^\circ\text{C}$ $T_A = 85^\circ\text{C}$ | P_D | 2.5 1.3 | 1.3 0.7 | W |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | -55 to +150 | | $^\circ\text{C}$ |

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

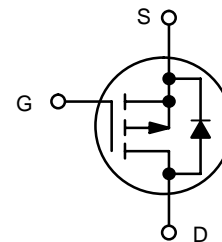
1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).



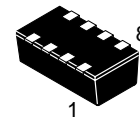
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<http://onsemi.com>

| $V_{(BR)DSS}$ | $R_{DS(on)}$ TYP | I_D MAX |
|---------------|------------------------|-----------|
| -20 V | 46 m Ω @ -4.5 V | -5.3 A |

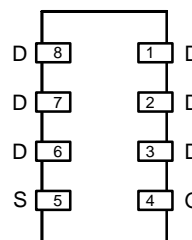


P-Channel MOSFET

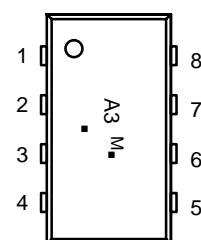


ChipFET
CASE 1206A
STYLE 1

PIN CONNECTIONS



MARKING DIAGRAM



A3 = Specific Device Code

M = Month Code

▪ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping† |
|-------------|-------------------|------------------|
| NTHS5441T1 | ChipFET | 3000/Tape & Reel |
| NTHS5441T1G | ChipFET (Pb-Free) | 3000/Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NTHS5441

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Typ | Max | Unit |
|--|-----------------|----------|----------|-----------------------------|
| Maximum Junction-to-Ambient (Note 2) $t \leq 5$ sec Steady State | $R_{\theta JA}$ | 40 80 | 50 95 | $^{\circ}\text{C}/\text{W}$ |
| Maximum Junction-to-Foot (Drain) Steady State | $R_{\theta JF}$ | 15 | 20 | $^{\circ}\text{C}/\text{W}$ |

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Test Condition | Min | Typ | Max | Unit |
|---|--------------|--|------|----------------|-----------|---------------|
| Static | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$ | -0.6 | | -1.2 | V |
| Gate-Body Leakage | I_{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ | | | -1.0 | μA |
| | | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^{\circ}\text{C}$ | | | -5.0 | |
| On-State Drain Current (Note 3) | $I_{D(on)}$ | $V_{DS} \leq -5.0 \text{ V}, V_{GS} = -4.5 \text{ V}$ | -20 | | | A |
| Drain-Source On-State Resistance (Note 3) | $r_{DS(on)}$ | $V_{GS} = -3.6 \text{ V}, I_D = -3.7 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -3.9 \text{ A}$ | - | 0.050 0.046 | 0.06 - | Ω |
| | | $V_{GS} = -2.5 \text{ V}, I_D = -3.1 \text{ A}$ | | 0.070 | 0.083 | |
| Forward Transconductance (Note 3) | g_{fs} | $V_{DS} = -10 \text{ V}, I_D = -3.9 \text{ A}$ | | 12 | | mhos |
| Diode Forward Voltage (Note 3) | V_{SD} | $I_S = -2.1 \text{ A}, V_{GS} = 0 \text{ V}$ | | -0.8 | -1.2 | V |

Dynamic (Note 4)

| | | | | | | |
|------------------------------------|--------------|---|--|-----|-----|---------------|
| Total Gate Charge | Q_G | $V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -3.9 \text{ A}$ | | 9.7 | 22 | nC |
| Gate-Source Charge | Q_{GS} | | | 1.2 | | |
| Gate-Drain Charge | Q_{GD} | | | 3.6 | | |
| Input Capacitance | C_{iss} | $V_{DS} = -5.0 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz}$ | | 710 | | μF |
| Output Capacitance | C_{oss} | | | 400 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 140 | | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = -10 \text{ V}, R_L = 10 \Omega, I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_G = 6 \Omega$ | | 14 | 30 | ns |
| Rise Time | t_r | | | 22 | 55 | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | 42 | 100 | |
| Fall Time | t_f | | | 35 | 70 | |
| Source-Drain Reverse Recovery Time | t_{rr} | $I_F = -1.1 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$ | | 30 | 60 | |

2. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).

3. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.

4. Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

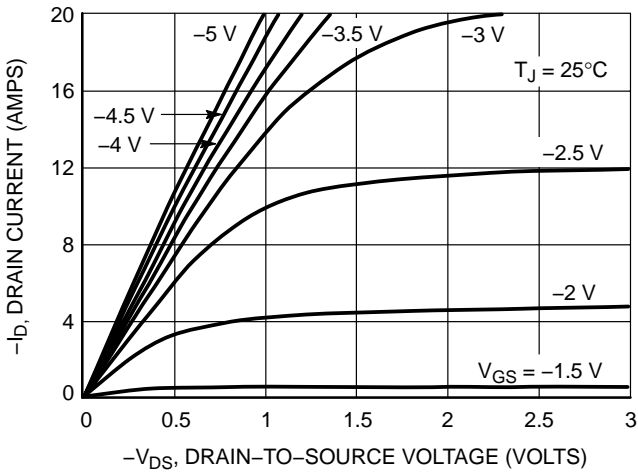


Figure 1. On-Region Characteristics

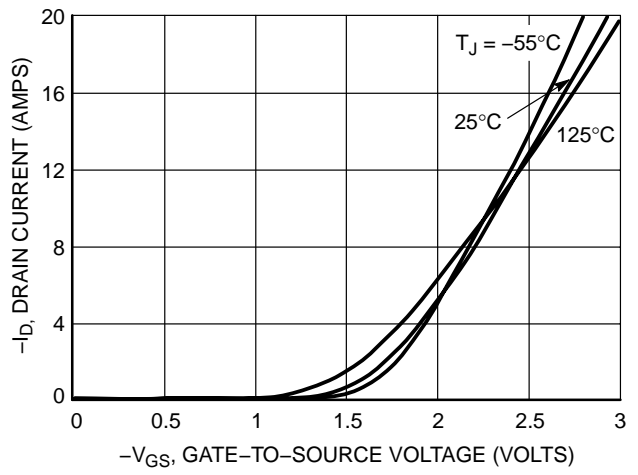


Figure 2. Transfer Characteristics

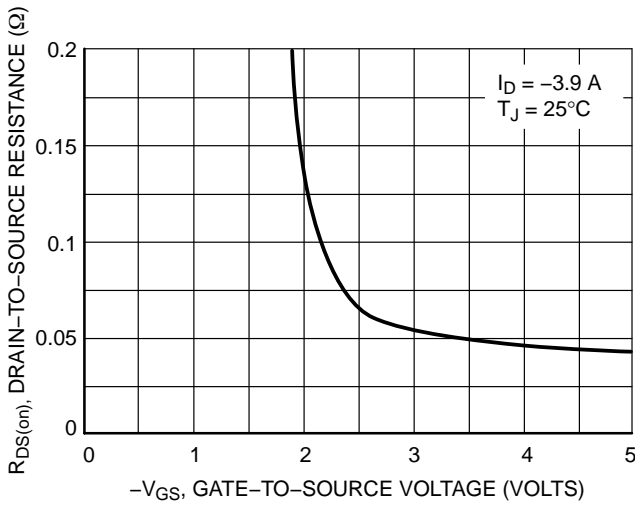


Figure 3. On-Resistance versus Gate-to-Source Voltage

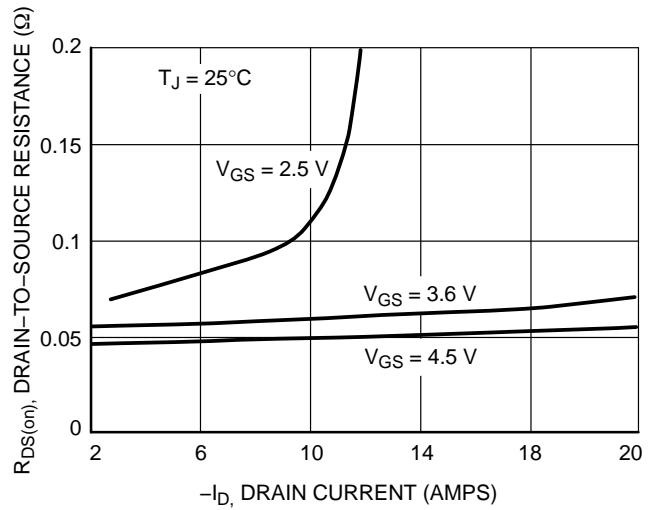


Figure 4. On-Resistance versus Drain Current and Gate Voltage

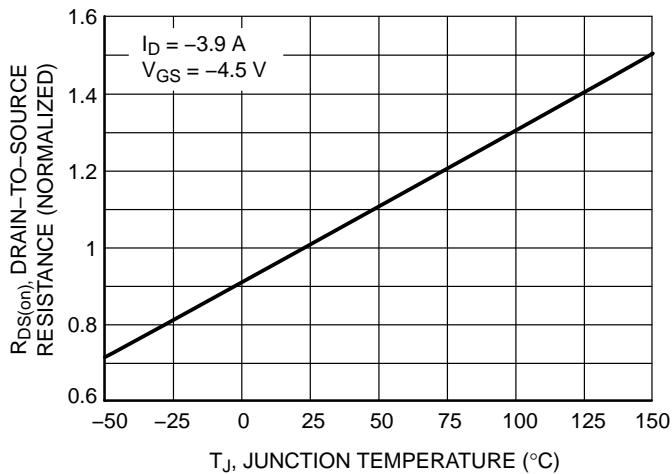


Figure 5. On-Resistance Variation with Temperature

TYPICAL ELECTRICAL CHARACTERISTICS

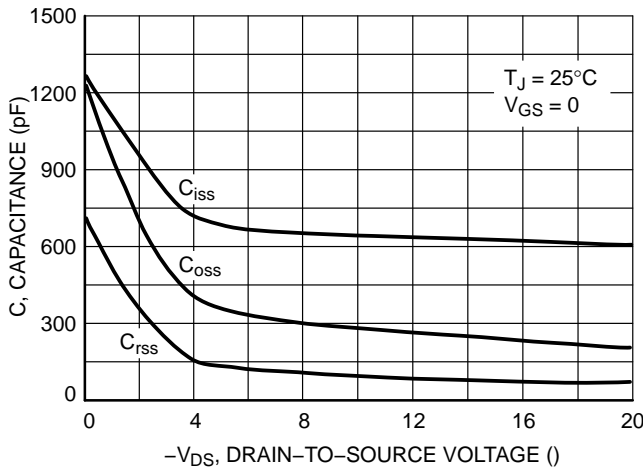


Figure 6. Capacitance Variation

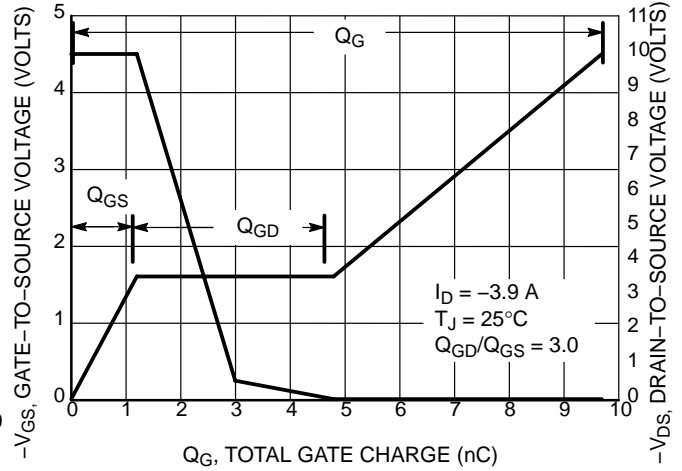


Figure 7. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

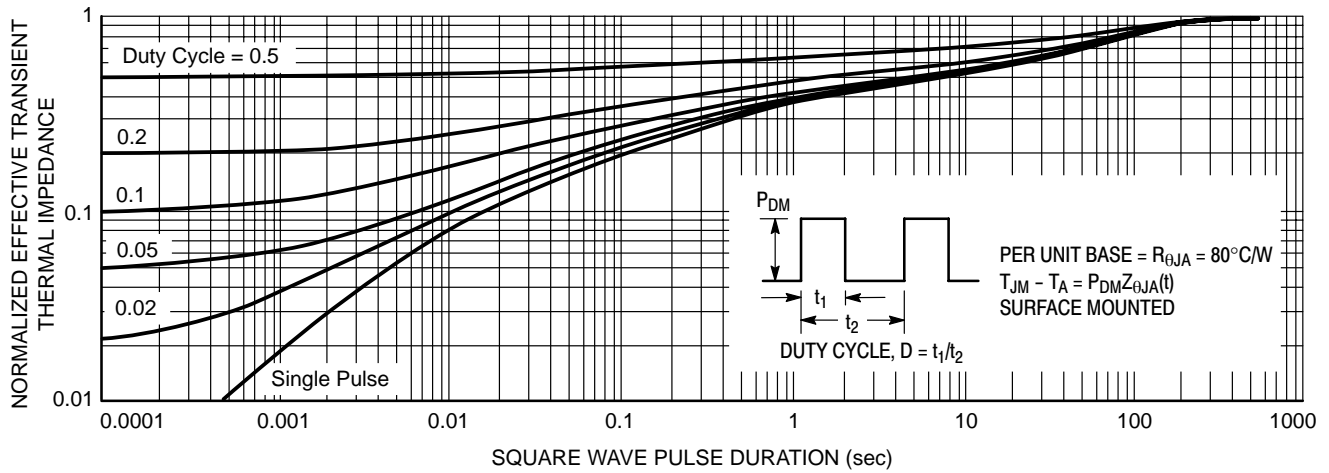


Figure 8. Normalized Thermal Transient Impedance, Junction-to-Ambient

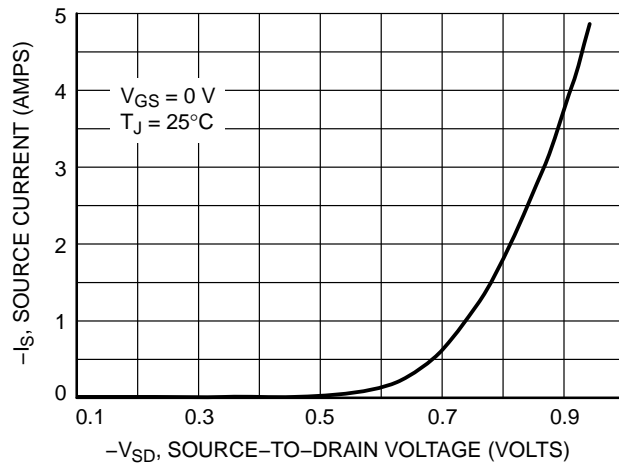
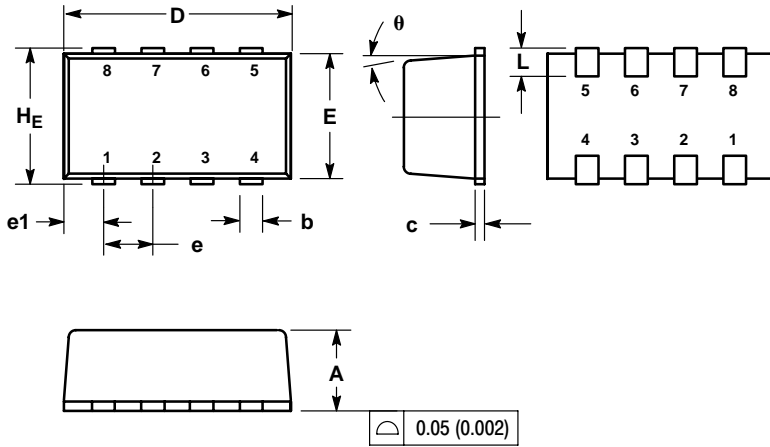


Figure 9. Diode Forward Voltage versus Current

NTHS5441

PACKAGE DIMENSIONS

ChipFET™ CASE 1206A-03 ISSUE G

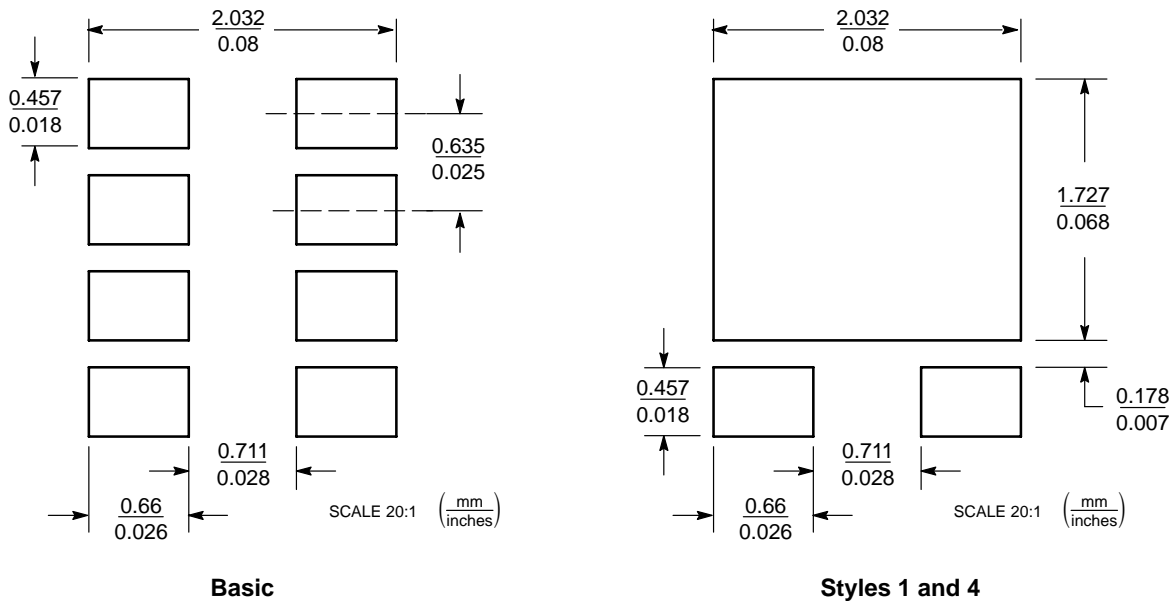


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.


| DIM | MILLIMETERS | | | INCHES | | |
|-----|-------------|------|------|-----------|-------|-------|
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 1.00 | 1.05 | 1.10 | 0.039 | 0.041 | 0.043 |
| b | 0.25 | 0.30 | 0.35 | 0.010 | 0.012 | 0.014 |
| c | 0.10 | 0.15 | 0.20 | 0.004 | 0.006 | 0.008 |
| D | 2.95 | 3.05 | 3.10 | 0.116 | 0.120 | 0.122 |
| E | 1.55 | 1.65 | 1.70 | 0.061 | 0.065 | 0.067 |
| e | 0.65 BSC | | | 0.025 BSC | | |
| e1 | 0.55 BSC | | | 0.022 BSC | | |
| L | 0.28 | 0.35 | 0.42 | 0.011 | 0.014 | 0.017 |
| HE | 1.80 | 1.90 | 2.00 | 0.071 | 0.075 | 0.079 |
| θ | 5° NOM | | | 5° NOM | | |

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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